

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination NARDIN ET AL.	
		Examiner Dwin M Craig	Art Unit 2123	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Arai Sinha, Sandeep K. Gupta and Melvin A. Breuer, "Validation and Test Generation for Oscillatory Noise in VLSI Interconnects", November 1999, IEEE, pp. 289-296.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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